

September 1998

Features

- 1A, 120V and 150V
- $r_{DS(ON)} = 1.900\Omega$

Ordering Information

PART NUMBER	PACKAGE	BRAND
RFL1N12L	TO-205AF	RFL1N12L
RFL1N15L	TO-205AF	RFL1N15L

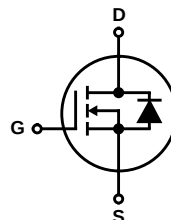
NOTE: When ordering, use the entire part number.

Description

These are N-Channel enhancement mode silicon gate power field effect transistors specifically designed for use with logic level (5V) driving sources in applications such as programmable controllers, automotive switching, and solenoid drivers. This performance is accomplished through a special gate oxide design which provides full rated conduction at gate biases in the 3V to 5V range, thereby facilitating true on-off power control directly from logic circuit supply voltages.

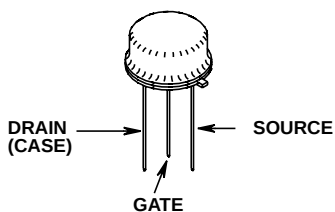
Formerly developmental type TA09528.

Symbol



Packaging

JEDEC TO-205AF



RFL1N12L, RFL1N15L

Absolute Maximum Ratings $T_C = 25^{\circ}\text{C}$, Unless Otherwise Specified

	RFL1N12L	RFL1N15L	UNITS
Drain to Source Voltage (Note 1) V_{DS}	120	150	V
Drain to Gate Voltage ($R_{GS} = 1\text{M}\Omega$) (Note 1) V_{DGR}	120	150	V
Continuous Drain Current I_D	1	1	A
Pulsed Drain Current (Note 3) I_{DM}	5	5	A
Gate to Source Voltage V_{GS}	± 10	± 10	V
Maximum Power Dissipation P_D	8.33	8.33	W
Above $T_C = 25^{\circ}\text{C}$, Derate Linearly	0.0667	0.0667	W/ $^{\circ}\text{C}$
Operating and Storage Temperature T_J, T_{STG}	-55 to 150	-55 to 150	$^{\circ}\text{C}$
Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10s T_L	260	260	$^{\circ}\text{C}$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $T_J = 25^{\circ}\text{C}$ to 125°C .

Electrical Specifications $T_C = 25^{\circ}\text{C}$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage RFL1N12L	BV_{DSS}	$I_D = 250\mu\text{A}, V_{GS} = 0$	120	-	-	V
RFL1N15L			150	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$, (Figure 8)	1	-	2	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = \text{Rated } BV_{DSS}$	-	-	1	μA
		$V_{DS} = 0.8 \times \text{Rated } BV_{DSS}, T_C = 125^{\circ}\text{C}$	-	-	25	μA
Gate to Source Leakage Current	I_{GSS}	$V_{GS} = \pm 10\text{V}, V_{DS} = 0$	-	-	± 100	μA
Drain to Source On Resistance (Note 2)	$r_{DS(ON)}$	$I_D = 1\text{A}, V_{GS} = 5\text{V}$, (Figures 6, 7)	-	-	1.900	Ω
Drain to Source On Voltage (Note 2)	$V_{DS(ON)}$	$I_D = 1\text{A}, V_{GS} = 5\text{V}$	-	-	1.9	V
Turn-On Delay Time	$t_{d(ON)}$	$I_D \approx 1\text{A}, V_{DD} = 75\text{V}, R_G = 6.25\Omega$, $R_L = 75\Omega, V_{GS} = 5\text{V}$, (Figures 10, 11, 12)	-	10	25	ns
Rise Time	t_r		-	10	45	ns
Turn-Off Delay Time	$t_{d(OFF)}$		-	24	45	ns
Fall Time	t_f		-	30	50	ns
Input Capacitance	C_{ISS}	$V_{GS} = 0\text{V}, V_{DS} = 25\text{V}, f = 1\text{MHz}$, (Figure 9)	-	-	200	pF
Output Capacitance	C_{OSS}		-	-	80	pF
Reverse Transfer Capacitance	C_{RSS}		-	-	35	pF
Thermal Resistance Junction to Case	$R_{\theta JC}$		-	-	15	$^{\circ}\text{C/W}$

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Source to Drain Diode Voltage (Note 2)	V_{SD}	$I_{SD} = 1\text{A}$	-	-	1.4	V
Diode Reverse Recovery Time	t_{rr}	$I_{SD} = 1\text{A}, dI_{SD}/dt = 50\text{A}/\mu\text{s}$	-	150	-	ns

NOTES:

2. Pulse test: width $\leq 300\mu\text{s}$ duty cycle $\leq 2\%$.
3. Repetitive rating: pulse width limited by maximum junction temperature.

Typical Performance Curves Unless Otherwise Specified

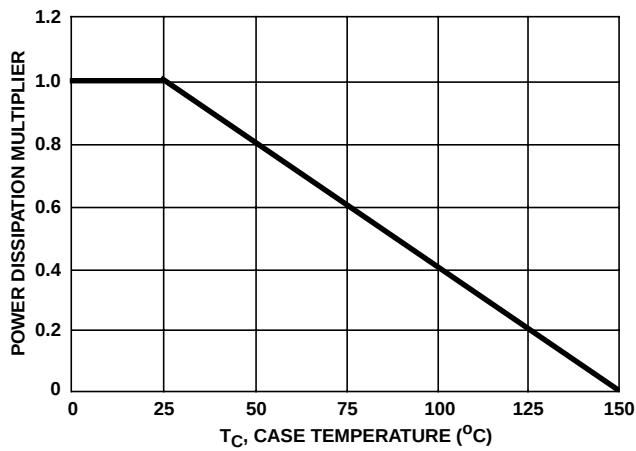


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

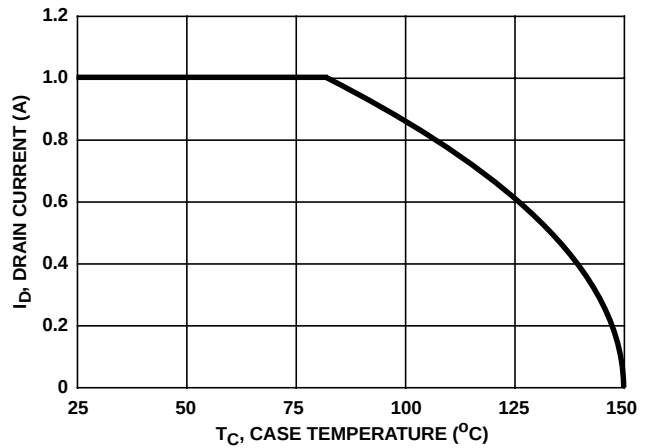


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

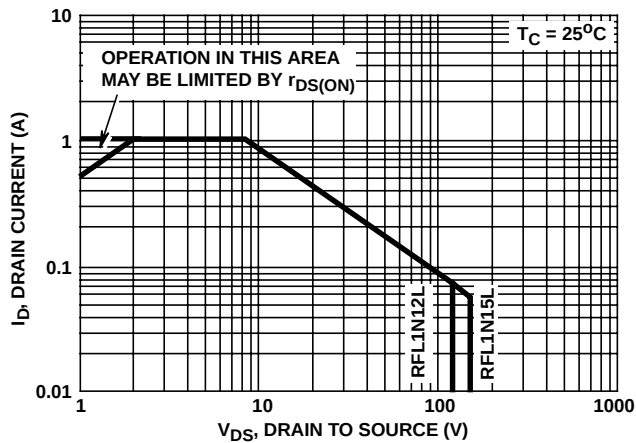


FIGURE 3. FORWARD BIAS SAFE OPERATING AREA

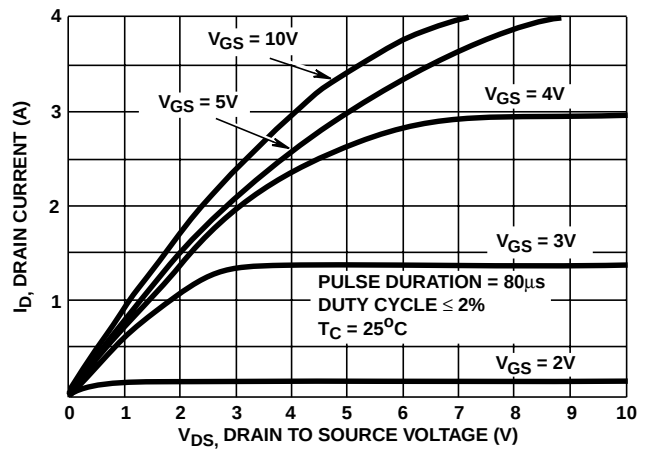


FIGURE 4. SATURATION CHARACTERISTICS

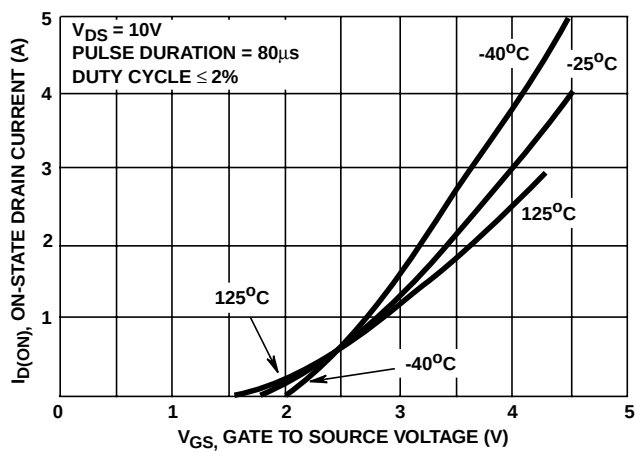


FIGURE 5. TRANSFER CHARACTERISTICS

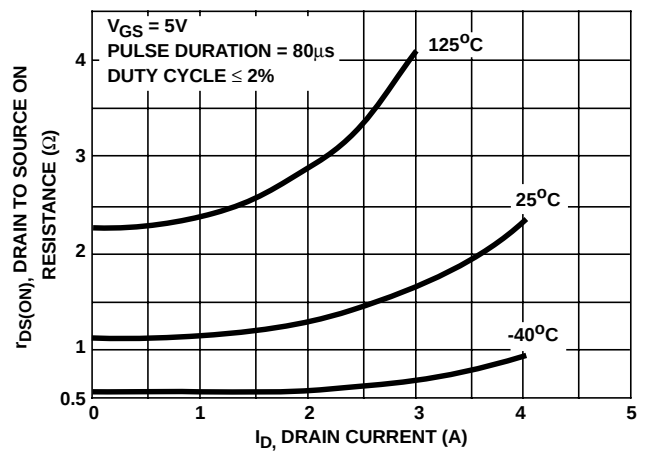


FIGURE 6. DRAIN TO SOURCE ON RESISTANCE vs DRAIN CURRENT

Typical Performance Curves Unless Otherwise Specified (Continued)

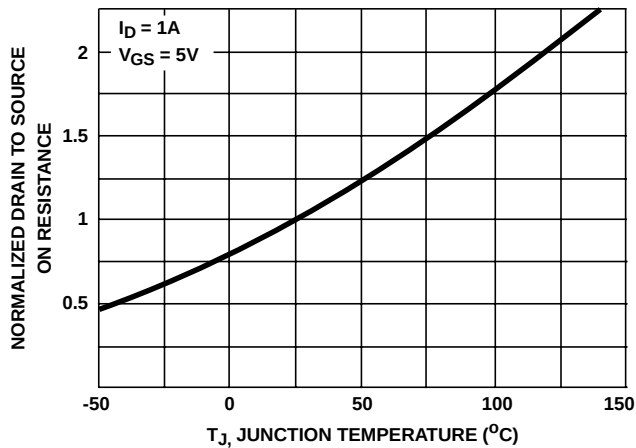


FIGURE 7. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

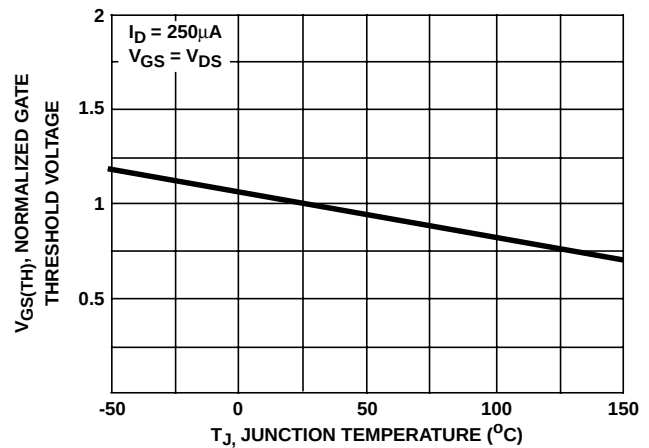


FIGURE 8. NORMALIZED GATE THRESHOLD VOLTAGE vs JUNCTION TEMPERATURE

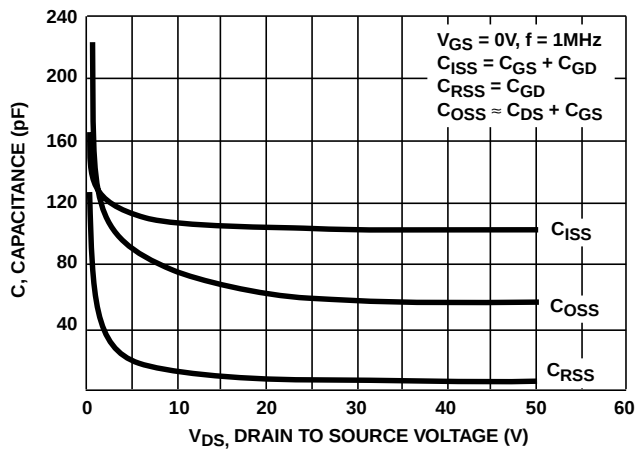
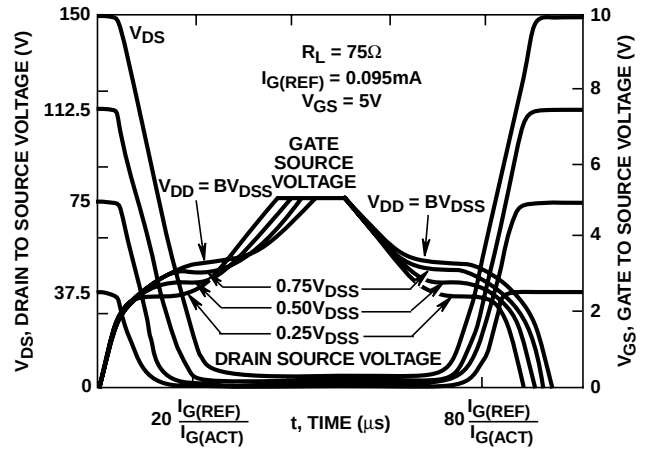


FIGURE 9. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE



NOTE: Refer to Harris Application Notes AN7254 and AN7260.

FIGURE 10. NORMALIZED SWITCHING WAVEFORMS FOR CONSTANT GATE CURRENT

Test Circuits and Waveforms

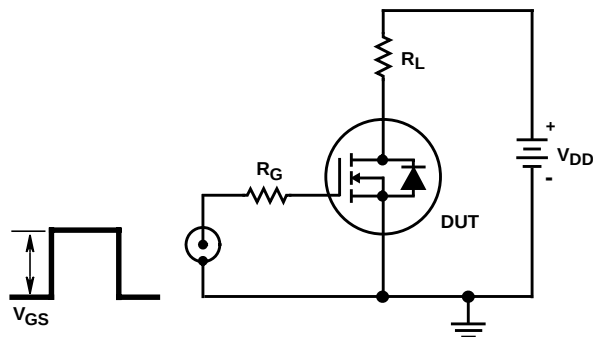


FIGURE 11. SWITCHING TIME TEST CIRCUIT

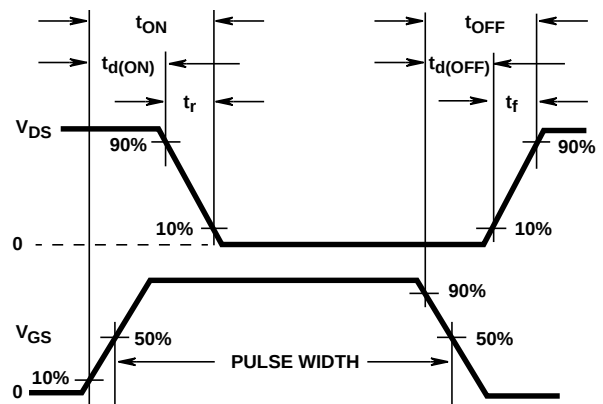


FIGURE 12. RESISTIVE SWITCHING WAVEFORMS